

# IRFI624GPBF-VB Datasheet **Power MOSFET**

PRODUCT SUMI	MARY				
V <sub>DS</sub> (V)	250	0			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	1.1			
Q <sub>g</sub> (Max.) (nC)	14				
Q <sub>gs</sub> (nC)	2.7	7			
Q <sub>gd</sub> (nC)	7.8	7.8			
Configuration	Sing	gle			

#### **FEATURES**

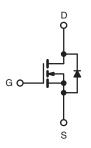
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





#### **TO-220 FULLPAK**





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	250	V	
Gate-Source Voltage			$V_{GS}$	± 20		
Ocalia a a Buia Ocala		$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		4.4		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	2.8	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	14		
Linear Derating Factor				0.40	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	100	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	4.4	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	5.0	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	$P_{D}$	17	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	for 10 s		300 <sup>d</sup>	7 ~	
Mariathar Tana	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque	0-3∠ Or I	vio screw	-	1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 8.3 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 4.4 A (see fig. 12).
- c.  $I_{SD} \le 4.4$  A,  $dI/dt \le 90$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATI	NGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	2.5	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•	•	,
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	0 V, I <sub>D</sub> = 250 μA	250	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 1 mA	-	0.36	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = \	/ <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	Vo	<sub>SS</sub> = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	l	V <sub>DS</sub> = 2	250 V, V <sub>GS</sub> = 0 V	-	-	25	μA
Zero Gate Voltage Drain Gurrent	I <sub>DSS</sub>	$V_{DS} = 200 \text{ V},$	$V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$	-	-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 2.6 A^b$	ı	1.1	-	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = \xi$	$50 \text{ V}, I_D = 2.6 \text{ A}^b$	1.5	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 \text{ V},$	1	260	-	
Output Capacitance	C <sub>oss</sub>	V	$V_{DS} = 25 \text{ V},$		77	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0	MHz, see fig. 5	-	15	-	
Total Gate Charge	Qg			-	-	14	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V},$	$I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	2.7	
Gate-Drain Charge	$Q_{gd}$	]	see lig. 6 and 13	-	-	7.8	
Turn-On Delay Time	t <sub>d(on)</sub>			-	7.0	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 125 \text{ V, } I_D = 4.4 \text{ A,}$ $R_g = 18 \ \Omega, \ R_D = 28 \ \Omega, \ \text{see fig. } 10^b$		-	13	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	20	-	
Fall Time	t <sub>f</sub>			-	12	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.4	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	14	Α
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I	l <sub>S</sub> = 4.4 A, V <sub>GS</sub> = 0 V <sup>b</sup>	1	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 4.4 A, dI/dt = 100 A/µs <sup>b</sup>		-	200	400	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.93	1.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turr	n-on time is negligible (turn	-on is do	minated b	ov Le and	LD)

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

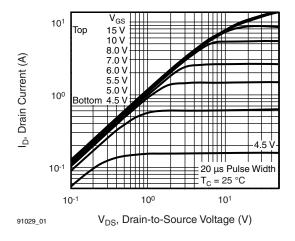


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

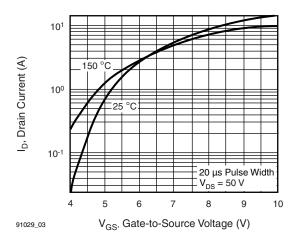


Fig. 3 - Typical Transfer Characteristics

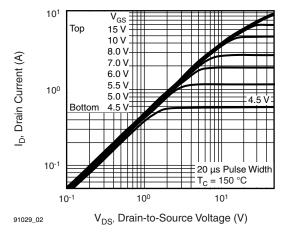


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

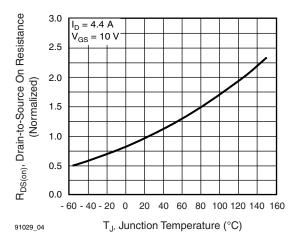


Fig. 4 - Normalized On-Resistance vs. Temperature



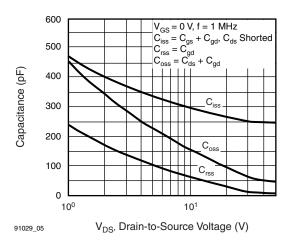


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

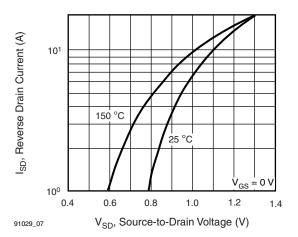


Fig. 7 - Typical Source-Drain Diode Forward Voltage

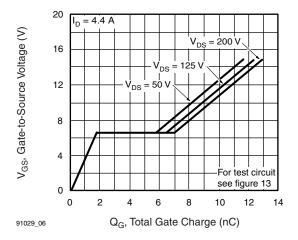


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

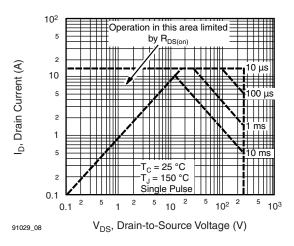


Fig. 8 - Maximum Safe Operating Area



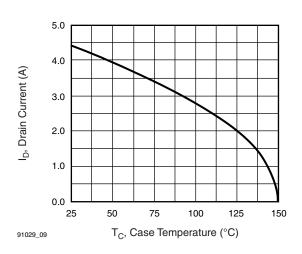


Fig. 9 - Maximum Drain Current vs. Case Temperature

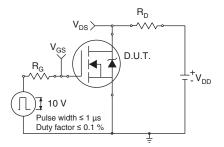


Fig. 10a - Switching Time Test Circuit

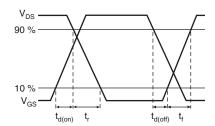


Fig. 10b - Switching Time Waveforms

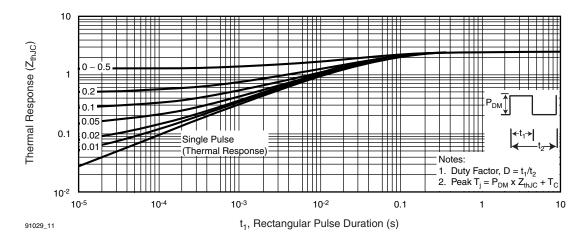


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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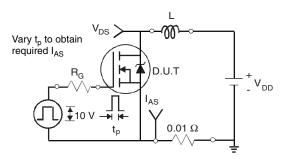


Fig. 12a - Unclamped Inductive Test Circuit

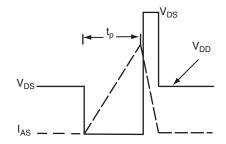


Fig. 12b - Unclamped Inductive Waveforms

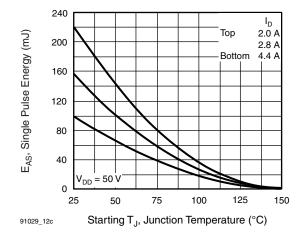


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

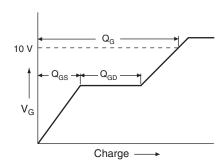


Fig. 13a - Basic Gate Charge Waveform

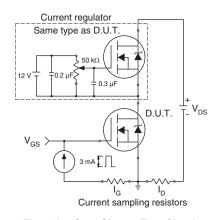
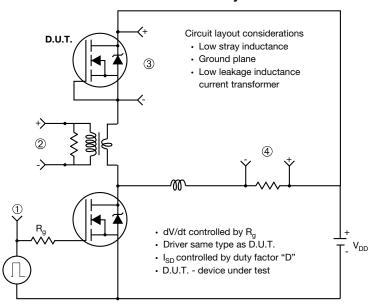


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



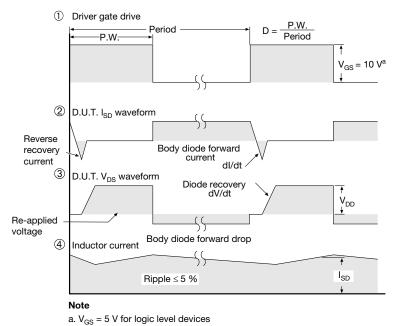
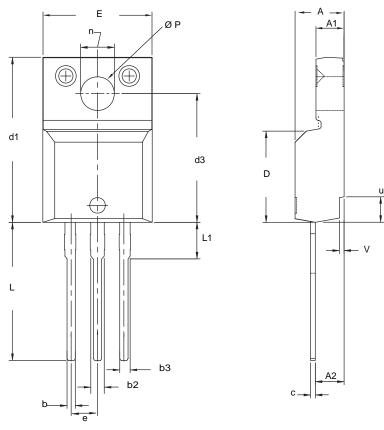


Fig. 14 - For N-Channel



### **TO-220 FULLPAK (HIGH VOLTAGE)**



DIM.	MILLIN	METERS	INC	HES
	MIN.	MAX.	MIN.	MAX.
Α	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
Е	10.360	10.630	0.408	0.419
е	2.54	BSC	0.100	BSC
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØР	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

DWG: 5972

#### Notes

- To be used only for process drawing.
  These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
  All critical dimensions should C meet C<sub>pk</sub> > 1.33.
  All dimensions include burrs and plating thickness.

- 5. No chipping or package damage.



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